Search Notes

Application/Control No.	Applicant(s)/Patent unde Reexamination	er
10/724,872	YAMAZAKI ET AL.	
Examiner	Art Unit	
Joseph Nguyen	2815	

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	SEAR	CHED	
Class	Subclass	Date	Examiner
257	79,72	2/3/2006	JN
257	59	2/3/2006	JN
257	e33.072	2/3/2006	JN

INT	ERFERENC	ERENCE SEARCHED	
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
DATE	EXMR			
2/3/2006	JN			
	DATE			